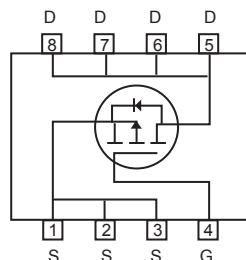
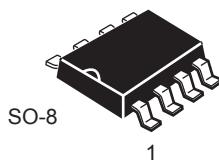


P-Channel Enhancement Mode Field Effect Transistor

PRELIMINARY

FEATURES

- -60V, -6A, $R_{DS(ON)} = 45m\Omega$ @ $V_{GS} = -10V$.
 $R_{DS(ON)} = 65m\Omega$ @ $V_{GS} = -4.5V$.
- Super high dense cell design for extremely low $R_{DS(ON)}$.
- High power and current handing capability.
- Lead free product is acquired.
- Surface mount Package.

ABSOLUTE MAXIMUM RATINGS $T_A = 25^\circ C$ unless otherwise noted

Parameter	Symbol	Limit	Units
Drain-Source Voltage	V_{DS}	-60	V
Gate-Source Voltage	V_{GS}	± 20	V
Drain Current-Continuous	I_D	-6	A
Drain Current-Pulsed ^a	I_{DM}	-24	A
Maximum Power Dissipation	P_D	2.5	W
Operating and Store Temperature Range	T_J, T_{Stg}	-55 to 150	$^\circ C$

Thermal Characteristics

Parameter	Symbol	Limit	Units
Thermal Resistance, Junction-to-Ambient ^b	$R_{\theta JA}$	50	$^\circ C/W$



CEM6355

Electrical Characteristics T_A = 25°C unless otherwise noted

5

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
Off Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D = -250µA	-60			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = -60V, V _{GS} = 0V			-1	µA
Gate Body Leakage Current, Forward	I _{GSSF}	V _{GS} = 20V, V _{DS} = 0V			100	nA
Gate Body Leakage Current, Reverse	I _{GSSR}	V _{GS} = -20V, V _{DS} = 0V			-100	nA
On Characteristics^c						
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D = -250µA	-1		-3	V
Static Drain-Source On-Resistance	R _{DS(on)}	V _{GS} = -10V, I _D = -6A		37	45	mΩ
		V _{GS} = -4.5V, I _D = -4.9A		50	65	mΩ
Dynamic Characteristics^d						
Forward Transconductance	g _{FS}	V _{DS} = -5V, I _D = -6A		10		S
Input Capacitance	C _{iss}	V _{DS} = -30V, V _{GS} = 0V, f = 1.0 MHz	2015			pF
Output Capacitance	C _{oss}			175		pF
Reverse Transfer Capacitance	C _{rss}			90		pF
Switching Characteristics^d						
Turn-On Delay Time	t _{d(on)}	V _{DD} = -30V, I _D = -6A, V _{GS} = -10V, R _{GEN} = 3Ω	14 3 46 10	28		ns
Turn-On Rise Time	t _r			6		ns
Turn-Off Delay Time	t _{d(off)}			92		ns
Turn-Off Fall Time	t _f			20		ns
Total Gate Charge	Q _g	V _{DS} = -30V, I _D = -6A, V _{GS} = -10V	32 5.5 5.2	42.6		nC
Gate-Source Charge	Q _{gs}					nC
Gate-Drain Charge	Q _{gd}					nC
Drain-Source Diode Characteristics and Maximum Ratings						
Drain-Source Diode Forward Current ^b	I _S				-6	A
Drain-Source Diode Forward Voltage ^c	V _{SD}	V _{GS} = 0V, I _S = -6A			-1.2	V

Notes :

a.Repetitive Rating : Pulse width limited by maximum junction temperature.

b.Surface Mounted on FR4 Board, t ≤ 10 sec.

c.Pulse Test : Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.

d.Guaranteed by design, not subject to production testing.

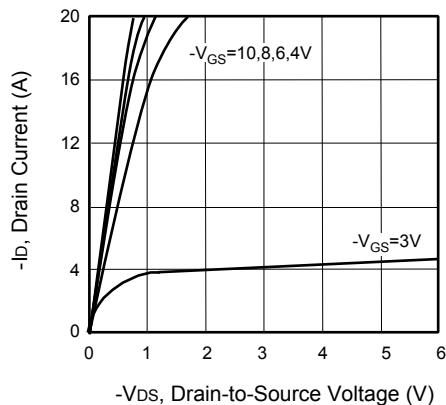


Figure 1. Output Characteristics

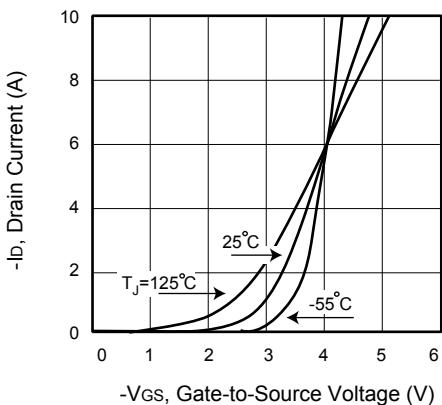


Figure 2. Transfer Characteristics

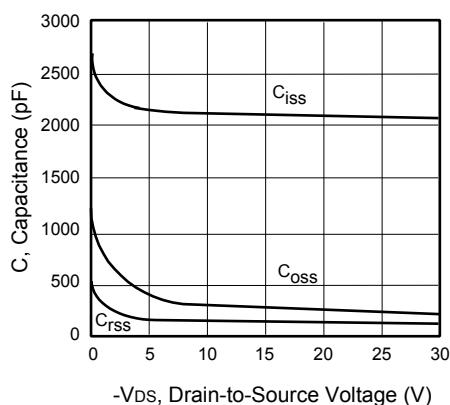


Figure 3. Capacitance

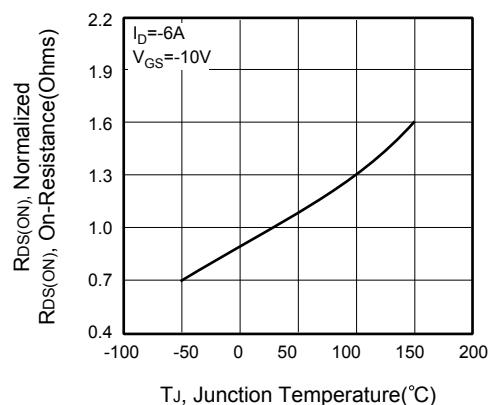


Figure 4. On-Resistance Variation with Temperature

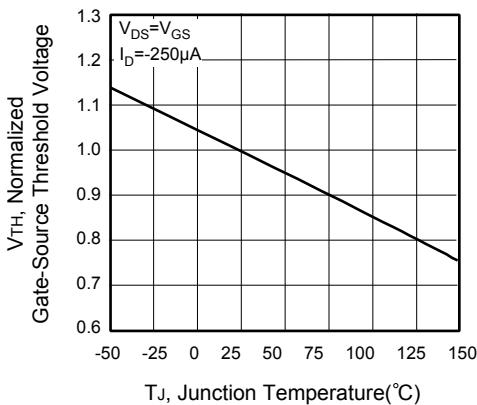


Figure 5. Gate Threshold Variation with Temperature

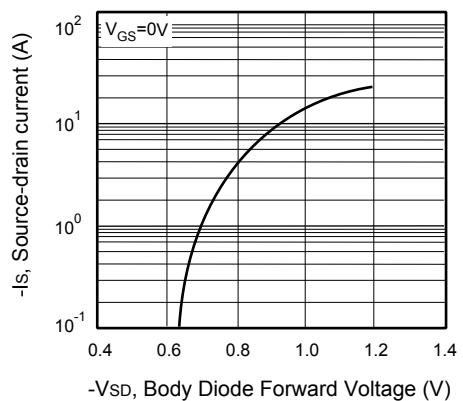


Figure 6. Body Diode Forward Voltage Variation with Source Current

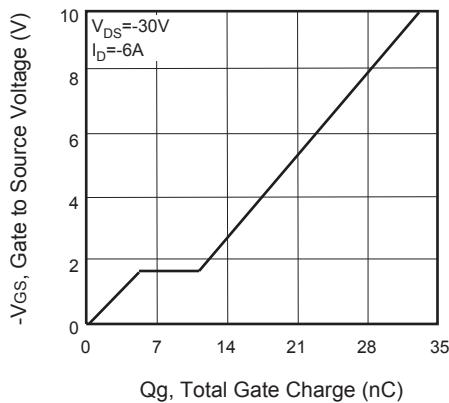


Figure 7. Gate Charge

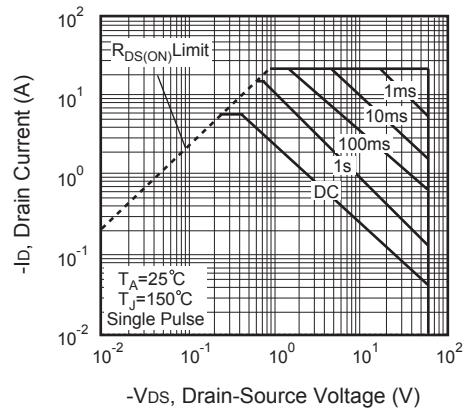


Figure 8. Maximum Safe Operating Area

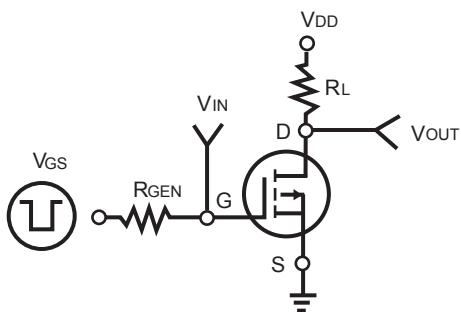


Figure 9. Switching Test Circuit

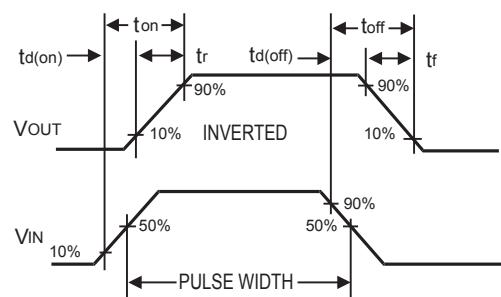


Figure 10. Switching Waveforms

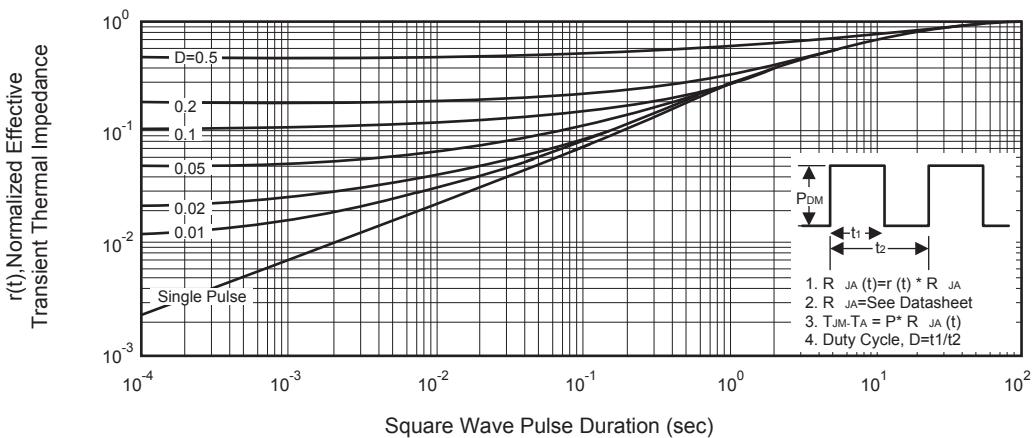


Figure 11. Normalized Thermal Transient Impedance Curve